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In Re Application Of: David S. Mui et al.

Serial No.

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Group Art Unit

09/905,172

ETCH PATTERN DEFINITION USING A CVD ORGANIC LAYER AS AN ANTI-REFLECTION COATING AND HARDMASK

TO THE ASSISTANT COMMISSIONER FOR PATENTS

Please send all correspondence for this application to:

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Dated: April 11, 2002

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I certify that this document is being deposited on -1/1/02 with the U.S. Poetal Service as first class mall under 57 C.F.R. 1.8 and is addressed to the Assistant Commissioner for Patents, Washington, D.C. 20231.

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